Search Notes		
	[[18]	

es	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/835,296	SANO ET AL.	
	Examiner	Art Unit	
	Son P. Huynh	2611	

	SEAR	CHED	
	SEAR	CHED	
Class	Subclass	Date	Examiner
725	39	6/6/2005	АН
348	734	6/6/2005	АН
		•	
			-

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	<u> </u>		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST TEXT SEARCH ENCLOSED	6/6/2005	АН
CHRIS GRANT (725)	6/1/2005	АН
· · · · · · · · · · · · · · · · · · ·		